## SIEMENS

## Data sheet

## 6AU1425-2AD00-0AA0



SIMOTION Drive-based Control Unit D425-2 DP/PN; programmable motion controller; BASIC performance; interfaces: 12 DI, 16 DI/DO, 4 DRIVE-CLiQ, 2 PROFIBUS, 3 PROFINET ports, 2 ethernet, 2 USB, 1 option slot; incl. dual fan / battery module and battery

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product brand name	SIMOTION				
product type designation	D425-2 DP/PN				
Performance class for motion control system	BASIC Performance				
Version of the motion control system	Multiple-axis system				
PLC and motion control performance					
number of axes / maximum	16				
Minimum PROFIBUS cycle clock	1 ms				
Minimum PROFINET send cycle clock	0.25 ms				
Minimum interpolator cycle clock	0.5 ms				
Minimum servo cycle clock	0.5 ms				
Integrated drive control / header					
Maximum number of axes for integrated drive control					
• Servo	6				
• vector	6				
• V/f	12				
• note	Alternative control modes; drive control based on SINAMICS S120 CU320-2, firmware version V4.x/V5.x				
Memory					
RAM (work memory)	78 Mbyte				
Additional RAM work memory for Java applications	20 Mbyte				
RAM disk (load memory)	38 Mbyte				
Retentive memory	364 kbyte				
Persistent memory (user data on CF)	1.5 Gbyte				
Communication					
Interfaces					
• DRIVE-CLIQ	4				
• USB	2				
Industrial Ethernet	2				
PROFIBUS	2				
— note	Equidistant and isochronous; Can be configured as master or slave				
PROFINET	1				
— note	1 interface with 3 ports onboard; 1 interface with 4 ports optional via CBE30-2; functionality: supports PROFINET IO with IRT and RT; configurable as PROFINET IO Controller and/or Device; supports media redundancy (MRP and MRPD)				
General technical data					
Fan	Double fan/battery module included in scope of delivery				
DC supply voltage					
<ul> <li>rated value</li> </ul>	24 V				
• minimum	20.4 V				

• maximum	28.8 V				
consumed current / typical	1 000 mA				
note	with no load on inputs/outputs, no 24 V supply via DRIVE-CLiQ and PROFIBUS interface				
Making current, typ.	5 A				
Power loss, typ.	24 W				
Ambient temperature, during					
long-term storage	-25 +55 °C				
• transport	-40 +70 °C				
operation	0 55 °C				
— note	Maximum installation altitude 4000 m (13124 ft) above sea level. Above an altitude of 2000 m (6562 ft), the maximum ambient temperature decreases by 7 °C (12.6 °F) per 1000 m (3281 ft).				
Relative humidity					
<ul> <li>during operation</li> </ul>	5 95 %				
<ul> <li>without condensation, tested acc. to IEC 60068-2-38</li> </ul>	Wert fehlt				
Product property / Conformal coating	No				
Resistance					
<ul> <li>to biologically active substances, / conformity acc. to EN 60721-3-3</li> </ul>	No				
to chemically active substances, / conformity acc. to EN     60721-3-3	No				
Air pressure	620 1 060 hPa				
Degree of protection	IP20 / UL open type				
height	380 mm				
width	50 mm				
• depth	270 mm				
Depth / Note	When the spacer is removed 230 mm (9.05 in) deep				
net weight	3 700 g				
Digital inputs / header					
number of digital inputs	12				
DC input voltage					
DC input voltage  • rated value	24 V				
DC input voltage • rated value • for signal "1"	24 V 15 30 V				
DC input voltage • rated value • for signal "1" • for signal "0"	24 V 15 30 V -3 +5 V				
DC input voltage • rated value • for signal "1" • for signal "0" Electrical isolation	24 V 15 30 V -3 +5 V Yes				
DC input voltage • rated value • for signal "1" • for signal "0" Electrical isolation • note	24 V 15 30 V -3 +5 V Yes Yes, in groups of 6				
DC input voltage • rated value • for signal "1" • for signal "0" Electrical isolation • note Current consumption for "1" signal level, typ.	24 V 15 30 V -3 +5 V Yes				
DC input voltage • rated value • for signal "1" • for signal "0" Electrical isolation • note Current consumption for "1" signal level, typ. Input delay time for	24 V 15 30 V -3 +5 V Yes Yes, in groups of 6 9 mA				
DC input voltage • rated value • for signal "1" • for signal "0" Electrical isolation • note Current consumption for "1" signal level, typ. Input delay time for • signal "0" $\rightarrow$ "1", typ.	24 V 15 30 V -3 +5 V Yes Yes, in groups of 6 9 mA 50 μs				
DC input voltage • rated value • for signal "1" • for signal "0" Electrical isolation • note Current consumption for "1" signal level, typ. Input delay time for • signal "0" $\rightarrow$ "1", typ. • signal "1" $\rightarrow$ "0", typ.	24 V 15 30 V -3 +5 V Yes Yes, in groups of 6 9 mA				
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DC input voltage • rated value • for signal "1" • for signal "0" Electrical isolation • note Current consumption for "1" signal level, typ. Input delay time for • signal "0" $\rightarrow$ "1", typ. • signal "0" $\rightarrow$ "1", typ. • signal "1" $\rightarrow$ "0", typ. Digital inputs/outputs / header Number of digital I/Os	24 V 15 30 V -3 +5 V Yes Yes, in groups of 6 9 mA 50 μs 150 μs				
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DC input voltage • rated value • for signal "1" • for signal "0" Electrical isolation • note Current consumption for "1" signal level, typ. Input delay time for • signal "0" $\rightarrow$ "1", typ. • signal "0" $\rightarrow$ "1", typ. • signal "1" $\rightarrow$ "0", typ. Digital inputs/outputs / header Number of digital I/Os Parameterization possibility of the digital I/Os If used as an input / header DC input voltage	24 V 15 30 V -3 +5 V Yes Yes, in groups of 6 9 mA 50 μs 150 μs 16 Can be parameterized - as DI - as DO - as probe input (max. 16) - as cam output (max. 8)				
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DC input voltage • rated value • for signal "1" • for signal "0" Electrical isolation • note Current consumption for "1" signal level, typ. Input delay time for • signal "0" $\rightarrow$ "1", typ. • signal "1" $\rightarrow$ "0", typ. Digital inputs/outputs / header Number of digital I/Os Parameterization possibility of the digital I/Os If used as an input / header DC input voltage • rated value • for signal "1" • for signal "0" Electrical isolation Current consumption for "1" signal level, typ. Input delay time for • signal "0" $\rightarrow$ "1", typ. • signal "0" $\rightarrow$ "1", typ. • signal "1" $\rightarrow$ "0", typ. Measuring input / reproducibility Measuring input / resolution If used as an output / header	24 V 15 30 V -3 +5 V Yes Yes, in groups of 6 9 mA 50 μs 150 μs 16 can be parameterized - as DI - as DO - as probe input (max. 16) - as cam output (max. 8) 24 V 15 30 V -3 +5 V No 9 mA 5 μs 50 μs 5 μs				

• maximum	28.8 V				
Electrical isolation	No				
Current carrying capacity for each output, max.	500 mA				
Leakage current, max.	2 mA				
Output delay for					
• signal "0" $\rightarrow$ "1", typ.	150 µs				
• signal "0" $\rightarrow$ "1", max.	400 µs				
• signal "1" $\rightarrow$ "0", typ.	75 µs				
• signal "1" $\rightarrow$ "0", max.	150 µs				
— note	Data for Vcc = 24 V; load 48 Ohm; "1" = 90 % VOut, "0" = 10 % VOut				
Cam output					
reproducibility	10 µs				
resolution	1 µs				
Switching frequency of the outputs for					
<ul> <li>resistive load, max.</li> </ul>	4 kHz				
<ul> <li>inductive load, max.</li> </ul>	2 Hz				
<ul> <li>lamp load, max.</li> </ul>	11 Hz				
Short-circuit protection	Yes				
Additional technical data					
Back-up of non-volatile data					
<ul> <li>of retentive data</li> </ul>	unlimited buffer duration				
<ul> <li>of real-time clock, min.</li> </ul>	4 d				
• note	longer buffer duration of the real-time clock using a battery inserted in the double fan/battery module				
Approvals					
• USA	cULus				
• Canada	cULus				
• Australia	RCM (formerly C-Tick)				
• Korea	KCC				
<ul> <li>Russia, Belarus and Kazakhstan</li> </ul>	EAC				

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